

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

# PRODUCT SPECIFICATION 規格書

CUSTOMER: DATE:

(客戶): 志盛翔 (日期): 2018-07-27

CATEGORY (品名) : ALUMINUM ELECTROLYTIC CAPACITORS

DESCRIPTION (型号) : RT 450V120μF(φ18X35)

VERSION (版本) : 01

Customer P/N :

SUPPLIER :

SUPPLIER						
PREPARED (拟定)	CHECKED (审核)					
孟庆庆	刘渭清					

CUSTOMER							
APPROVAL (批准)	SIGNATURE (签名)						

# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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		RT SERIE					
Rev.	Date	Mark	Page	Contents	Purpose	Drafter	Approver

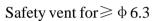
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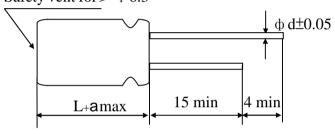
# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

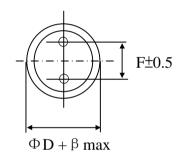
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Unit: mm

Table 1 Product Dimensions and Characteristics







а	L<20 : a=1.5; L≥20 : a=2.0
β	$\Phi D < 20 : \beta = 0.5; \ \Phi D \ge 20 : \beta = 1.0$

\* If it is flat rubber, there is no bulge from the flat rubber surface.

N	SAMXON	Part No. (Vdc) (uF) Cap. tolerance range (°C) (120Hz, Current	_	Current at 105°C   Eou a		Dim	Sleeve						
0.	Part No.			(μA,2min)	(mA rms)	(Hrs)	$D \times L$	F	фd				
1	ERT127M2WL35RR**F	450	120	-20%~+20%	-25~105	0.20	1105	2218	5000	18X35	7.5	0.8	PET

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**Attachment: Application Guidelines** 

# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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12~15

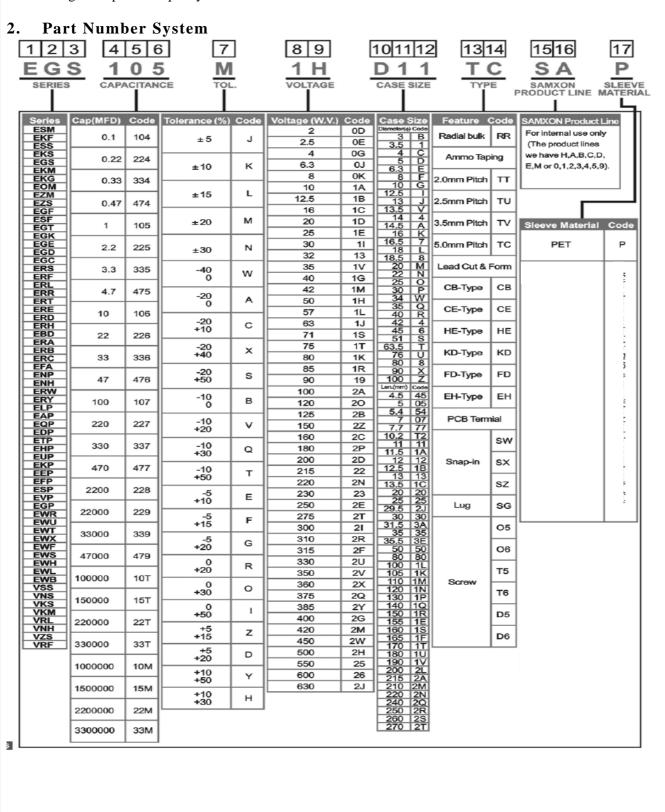
# CONTENTS **Sheet** 4 Application 1. Part Number System 4 3. Construction 5 4. Characteristics 5~10 4.1 Rated voltage & Surge voltage 4.2 Capacitance (Tolerance) 4.3 Leakage current 4.4 $\tan \delta$ 4.5 Terminal strength 4.6 Temperature characteristic 4.7 Load life test 4.8 Shelf life test 4.9 Surge test 4.10 Vibration 4.11 Solderability test 4.12 Resistance to solder heat 4.13 Change of temperature 4.14 Damp heat test 4.15 Vent test 4.16 Maximum permissible (ripple current) 5. List of "Environment-related Substances to be Controlled ('Controlled 11 Substances')"

# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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### 1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

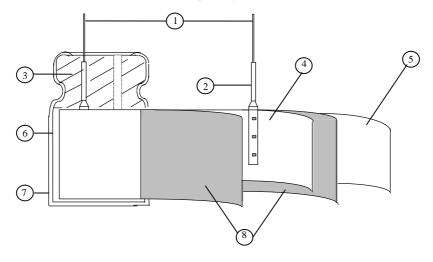


# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

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### 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

#### 4. Characteristics

#### Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature :15°C to 35°C
Relative humidity : 45% to 85%
Air Pressure : 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature  $: 20^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Relative humidity : 60% to 70%Air Pressure : 86kPa to 106kPa

#### Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

	ITEM				PE	RFORM	<b>IANCE</b>	3			
	Rated voltage (WV)			Γ				T	T	T	
	(** *)	WV (V.DC)	160	200	220	250	350	400	420	450	500
4.1		SV (V.DC)	200	250	270	300	400	450	470	500	550
	Surge voltage (SV)										
4.2	Nominal capacitance (Tolerance)	Measuring F Measuring V Measuring T <criteria></criteria>	Condition> Measuring Frequency : 120Hz±12Hz Measuring Voltage : Not more than 0.5Vrms Measuring Temperature : 20±2℃  Criteria> Shall be within the specified capacitance tolerance.								
4.3	Leakage current	<condition> Connecting to minutes, and  <criteria> Refer to Table</criteria></condition>	the cap					etor (1	k Ω ± 1	$0\Omega$ ) in	series fo
4.4	tan δ	See 4.2, Nor < Criteria >	<condition> See 4.2, Norm Capacitance, for measuring frequency, voltage and temperature.  <criteria> Refer to Table 1</criteria></condition>								
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4.5	Terminal	Diamet	er of le	ad wire	; ]	ensile i kg)	force N gf)			g force (gf)	N
	strength	0.51	nm and	l less			0.51)			(0.25)	
		Over 0.	5mm to	0.8mn	n	10 (	1.0)		5 (	0.51)	
		< <b>Criteri</b> No notio		changes	shall b	e found	, no bre	akage (	or loose	ness at	the termir

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

1			<condition></condition>	Testing Ten	nerature (°	C)		Time		
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3				+						
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Load   life test   Criteria>   The characteristic shall meet the following requirements.   Leakage current   Value in 4.3 shall be satisfied   Capacitance Change   Within ±20% of initial value.   tan δ   Not more than 200% of the specified value.   Appearance   There shall be no leakage of electrolyte.			According to I $105^{\circ}\text{C} \pm 2 \text{ wit}$	h DC bias volt	age plus th	e rated ri	pple curr	ent for Ta	ble <b>1</b> . (	Γhe sum
<ul> <li>4.7 life test</li> <li>The characteristic shall meet the following requirements.</li> <li>Leakage current Value in 4.3 shall be satisfied         Capacitance Change Within ±20% of initial value.         tan δ Not more than 200% of the specified value.         Appearance There shall be no leakage of electrolyte.</li> <li>Condition&gt;         The capacitors are then stored with no voltage applied at a temperature of 105±2°C for 1000+48/0 hours. Following this period the capacitors shall be removed from the text chamber and be allowed to stabilized at room temperature for 4~8 hours. Next the shall be connected to a series limiting resistor(1k±100 Ω) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the stabilized at room temperature for 4~8 hours.</li> </ul>			According to I $105^{\circ}\text{C} \pm 2 \text{ wit}$ DC and ripple	h DC bias volt e peak voltage	age plus th shall not	e rated ri exceed	pple currethe rated	ent for Ta working	ible <b>1</b> . (7 voltage)	The sum (  ) Then the the state of the stat
The characteristic shall meet the following requirements.  Leakage current  Value in 4.3 shall be satisfied  Capacitance Change  Within $\pm 20\%$ of initial value.  tan $\delta$ Not more than 200% of the specified value.  Appearance  There shall be no leakage of electrolyte.   Condition>  The capacitors are then stored with no voltage applied at a temperature of $105\pm2^{\circ}\text{C}$ for $1000+48/0$ hours. Following this period the capacitors shall be removed from the tent chamber and be allowed to stabilized at room temperature for $4\sim8$ hours. Next the shall be connected to a series limiting resistor $(1k\pm100\Omega)$ with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the stabilized applied for 30min. After which the capacitors shall be discharged, and then, tested the stabilized at room temperature for $4\sim8$ hours.			According to I 105°C ±2 wit DC and ripple product should	h DC bias volt e peak voltage l be tested after	age plus the shall not 16 hours	e rated ri exceed	pple currethe rated	ent for Ta working	ible <b>1</b> . (7 voltage)	- Γhe sum ( ) Then tl
Leakage current Value in 4.3 shall be satisfied Capacitance Change Within $\pm 20\%$ of initial value.  tan $\delta$ Not more than 200% of the specified value.  Appearance There shall be no leakage of electrolyte.   Condition>  The capacitors are then stored with no voltage applied at a temperature of $105\pm 2^{\circ}\text{C}$ for $1000+48/0$ hours. Following this period the capacitors shall be removed from the ten chamber and be allowed to stabilized at room temperature for $4\sim 8$ hours. Next the shall be connected to a series limiting resistor $(1k\pm 100\Omega)$ with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged, and then, tested the shall be discharged.			According to I 105°C ±2 with DC and ripple product should result should n	h DC bias volt e peak voltage l be tested after	age plus the shall not 16 hours	e rated ri exceed	pple currethe rated	ent for Ta working	ible <b>1</b> . (7 voltage)	- Γhe sum ( ) Then tl
Capacitance Change Within $\pm 20\%$ of initial value. $tan \delta$ Not more than 200% of the specified value.  Appearance There shall be no leakage of electrolyte.  Condition>  The capacitors are then stored with no voltage applied at a temperature of $105\pm 2^{\circ}\text{C}$ for $1000+48/0$ hours. Following this period the capacitors shall be removed from the techamber and be allowed to stabilized at room temperature for $4\sim 8$ hours. Next the shall be connected to a series limiting resistor( $1k\pm 100\Omega$ ) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged.	4.7		According to I 105°C ±2 wit DC and ripple product should result should n < <b>Criteria</b> >	h DC bias volt e peak voltage I be tested after neet the follow	age plus the shall note 16 hours ing table:	e rated ri exceed recoverir	pple curre the rated ag time at	ent for Ta working	ible <b>1</b> . (7 voltage)	- Γhe sum ( ) Then tl
$\frac{\tan \delta}{\text{Appearance}} \qquad \text{Not more than 200\% of the specified value.} \\ \frac{\text{Appearance}}{\text{There shall be no leakage of electrolyte.}} \\ \frac{\text{Condition}}{\text{The capacitors are then stored with no voltage applied at a temperature of } 105 \pm 2^{\circ}\text{C for } 1000 + 48/0 \text{ hours.} \text{ Following this period the capacitors shall be removed from the temperature for } 4 - 8 \text{ hours.} \text{ Next the shall be connected to a series limiting resistor} (1k \pm 100 \Omega) \text{ with D.C. rated voltage } 4.8 \\ \text{life} \qquad \text{applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be connected to a series limiting resistor} \\ \text{All the shall be discharged, and then, tested the shall be discharged.} \\ \text{All the shall be connected to a series limiting resistor} \\ \text{All the shall be discharged, and then, tested the shall be discharged.} \\ \text{All the shall be connected to a series limiting resistor} \\ \text{All the shall be discharged, and then, tested the shall be discharged.} \\ \text{All the shall be discharged.} $	4.7	life	According to I 105°C ±2 with DC and ripple product should result should n < Criteria > The characteria	h DC bias volt e peak voltage I be tested after neet the follow istic shall meet	age plus the shall note 16 hours ing table:	e rated ri exceed recovering	pple curre the rated ng time at irements.	ent for Ta working atmospho	ible <b>1</b> . (7 voltage)	- Γhe sum ( ) Then tl
Appearance   There shall be no leakage of electrolyte.	4.7	life	According to I 105°C ±2 wit DC and ripple product should result should n < <b>Criteria&gt;</b> The characteri Leakage	h DC bias volt e peak voltage I be tested after neet the follow istic shall meet e current	age plus the shall note 16 hours ing table:  the follow	e rated ri exceed recovering ving require 4.3 sh	pple currenthe rated ag time at irements.	ent for Ta working atmospho	ible <b>1</b> . (7 voltage)	- Γhe sum ( ) Then tl
Condition> The capacitors are then stored with no voltage applied at a temperature of 105±2°C for 1000+48/0 hours. Following this period the capacitors shall be removed from the temperature and be allowed to stabilized at room temperature for 4~8 hours. Next the shall be connected to a series limiting resistor(1k±100Ω) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged.	4.7	life	According to I 105°C ±2 wit DC and ripple product should result should n < <b>Criteria&gt;</b> The characteri Leakage Capacit	h DC bias volt e peak voltage I be tested after neet the follow istic shall meet e current	age plus the shall note 16 hours ing table:  the follow  Value  Within	e rated ri exceed recovering ving require 4.3 shate ±20%	pple curre the rated ag time at irements. all be sati	ent for Ta working atmosphe sfied value.	uble <b>1</b> . (To voltage)	The sum (  ) Then the itions. The itions.
The capacitors are then stored with no voltage applied at a temperature of $105\pm2^{\circ}\text{C}$ for $1000+48/0$ hours. Following this period the capacitors shall be removed from the techamber and be allowed to stabilized at room temperature for $48$ hours. Next the shall be connected to a series limiting resistor( $1k\pm100\Omega$ ) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged.	4.7	life	According to I 105°C ±2 wit DC and ripple product should result should n < <b>Criteria&gt;</b> The characteri  Leakage Capacit tan δ	h DC bias volte e peak voltage I be tested after neet the follow istic shall meet e current ance Change	shall not 16 hours ing table: the follow Value Within	e rated riecvering require $\pm 20\%$ ore than $\pm 20\%$	pple curre the rated ag time at irements. all be sati of initial 200% of t	ent for Ta working atmosphe sfied value.	uble <b>1</b> . (To voltage) eric condition	The sum (  ) Then the itions. The itions.
The capacitors are then stored with no voltage applied at a temperature of $105\pm2^{\circ}\text{C}$ for $1000+48/0$ hours. Following this period the capacitors shall be removed from the techamber and be allowed to stabilized at room temperature for $48$ hours. Next the shall be connected to a series limiting resistor( $1k\pm100\Omega$ ) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged.	4.7	life	According to I 105°C ±2 wit DC and ripple product should result should n < <b>Criteria&gt;</b> The characteri  Leakage Capacit tan δ	h DC bias volte e peak voltage I be tested after neet the follow istic shall meet e current ance Change	shall not 16 hours ing table: the follow Value Within	e rated riecvering require $\pm 20\%$ ore than $\pm 20\%$	pple curre the rated ag time at irements. all be sati of initial 200% of t	ent for Ta working atmosphe sfied value.	uble <b>1</b> . (To voltage) eric condition	The sum (  ) Then the itions. The itions.
1000+48/0 hours. Following this period the capacitors shall be removed from the te chamber and be allowed to stabilized at room temperature for 4~8 hours. Next the shall be connected to a series limiting resistor(1k±100 Ω) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged.	4.7	life	According to I 105°C ±2 with DC and ripple product should result should	h DC bias volte e peak voltage I be tested after neet the follow istic shall meet e current ance Change	shall not 16 hours ing table: the follow Value Within	e rated riecvering require $\pm 20\%$ ore than $\pm 20\%$	pple curre the rated ag time at irements. all be sati of initial 200% of t	ent for Ta working atmosphe sfied value.	uble <b>1</b> . (To voltage) eric condition	The sum (  ) Then the itions. The itions.
chamber and be allowed to stabilized at room temperature for $4~8$ hours. Next the shall be connected to a series limiting resistor( $1k\pm 100\Omega$ ) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged.	4.7	life	According to I  105°C ±2 wit  DC and ripple product should result should n <criteria> The characteri  Leakage Capacit tan δ  Appears</criteria>	h DC bias volt e peak voltage I be tested after neet the follow istic shall meet e current ance Change	age plus the shall note 16 hours ing table:  the follow  Value  Within  Not me	e rated ri exceed recovering ving required in 4.3 shall ± 20% ore than 2 shall be re	pple curre the rated ag time at irements. all be sati of initial 200% of to no leakag	ent for Ta working atmosphe sfied value. the specif	voltage eric cond	The sum of Then the itions. The sum of Then the itions.
Shelf shall be connected to a series limiting resistor( $1k\pm 100 \Omega$ ) with D.C. rated voltage applied for 30min. After which the capacitors shall be discharged, and then, tested the shall be discharged and then the stead of the shall be discharged.	4.7	life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias volte peak voltage be tested after neet the follow sistic shall meet e current ance Change ance	shall not 16 hours ing table: the follow Value Within Not me	e rated ri exceed recovering ving requing 4.3 shand ±20% ore than 2 shall be re-	pple curre the rated ag time at irements. all be sati of initial 200% of the leakage	ent for Ta working atmosphe sfied value. the specifie of electron	voltage voltage eric cond ied value rolyte.	The sum of
4.8 life applied for 30min. After which the capacitors shall be discharged, and then, tested the	4.7	life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias volte peak voltage be tested after neet the follow istic shall meet e current ance Change are then stored urs. Following	the follow Within Not me There	e rated ri exceed recoverir  ving requind 4.3 sh a ± 20% ore than 2 shall be a  oltage app d the cap	pple curre the rated ag time at irements. all be sati of initial 200% of the no leakage	ent for Ta working atmosphe sfied value. the specif e of electronic temperaturall be ren	voltage, eric condition value rolyte.	The sum of
	4.7	life test	According to I  105°C ±2 wit  DC and ripple product should result should n <criteria> The characteri  Leakage Capacit tan δ  Appeara  <condition> The capacitors a  1000+48/0 hou chamber and b</condition></criteria>	h DC bias volt e peak voltage l be tested after neet the follow istic shall meet e current ance Change are then stored urs. Following be allowed to	shall not shall not 16 hours ing table:  the follow  Value  Within  Not me  There  with no votations period stabilized a	ving required the capation of	pple current the rated ag time at a lirements. The control of the	ent for Ta working atmosphe sfied value. the specifie of electronall be renall be renare for 4~	voltage voltage eric cond ied value rolyte.	The sum of the fitting the sum of
test characteristics.		life test	According to I  105°C ±2 wit  DC and ripple product should result should n <criteria> The characteri  Leakage Capacit tan δ  Appears  <condition> The capacitors a 1000+48/0 hou chamber and b shall be connected.</condition></criteria>	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to ected to a serie	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric cond ied value rolyte. ure of 10 noved fro 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting
		life test Shelf life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to exceed to a serimin. After whi	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric cond ied value rolyte. ure of 10 noved fro 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting
		life test Shelf life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to exceed to a serimin. After whi	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric cond ied value rolyte. ure of 10 noved fro 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting
		life test Shelf life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to exceed to a serimin. After whi	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric cond ied value rolyte. ure of 10 noved fro 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting
		life test Shelf life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to exceed to a serimin. After whi	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric cond ied value rolyte. ure of 10 noved fro 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting
		life test Shelf life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to exceed to a serimin. After whi	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric cond ied value rolyte. ure of 10 noved fro 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting
		life test Shelf life	According to I  105°C ±2 with DC and ripple product should result shoul	h DC bias voltage peak voltage be tested after neet the follow sistic shall meet e current ance Change are then stored urs. Following be allowed to exceed to a serimin. After whi	with no vo	ving required in 4.3 shall be resistored the capatroom of the resistored resistored in the capatroom of the	irements. all be sation leakage blied at a acitors sheemperatus (1k±100	sfied value. the specifie of electricall be removed the specificall by the specifical temperature for 4~	voltage eric condition ied value rolyte.  ure of 10 noved from 8 hours. D.C. rat	The sum of Then the itions. The itions. The itions of the terms of the terms of the itions of the iting

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

		<criteria></criteria>	
			neet the following requirements.
		Leakage current	Value in 4.3 shall be satisfied
	Shelf	Capacitance Change	Within $\pm 20\%$ of initial value.
4.8	life	tan $\delta$	Not more than 200% of the specified value.
	test	Appearance	There shall be no leakage of electrolyte.
			stored more than 1 year, the leakage current may
		-	through about 1 k $\Omega$ resistor, if necessary.
		<condition></condition>	
		Applied a surge voltage to the	capacitor connected with a $(100 \pm 50)/C_R (k\Omega)$ resistor.
			ed to 1000 cycles, each consisting of charge of $30 \pm 5s$ ,
		followed discharge of 5 min 3	
		The test temperature shall be	
		C <sub>R</sub> :Nominal Capacitance ( µ <b><criteria></criteria></b>	r)
4.9	Surge	Leakage current	Not more than the specified value.
7.7	test	Capacitance Change	Within $\pm 15\%$ of initial value.
		tan δ	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	There shall be no leakage of electrolyte.
			e at abnormal situation only. It is not applicable to such
		over voltage as often applied.	Transaction of the second of t
		<condition></condition>	
		The following conditions shal perpendicular directions.  Vibration frequency ran Peak to peak amplitude Sweep rate  Mounting method:	
			Within 30°
		4mm or less	
4.10	Vibration	<u> </u>	
	test		
		<criteria></criteria>	To be soldered
		After the test, the following	ng items shall be tested:
			No intermittent contacts, open or short
			circuiting. No damage of tab terminals or
			electrodes.  No mechanical damage in terminal. No leakage
			No mechanical damage in terminal. No leakage of electrolyte or swelling of the case.
			The markings shall be legible.

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		<condition></condition>						
		The capacitor shall be teste	ed under the following	conditions:				
		Soldering temperature	: 245±3°C					
		Dipping depth	: 2mm					
4.11	Solderability	Dipping speed	: 25±2.5mn	n/s				
	test	Dipping time	: 3±0.5s					
		<criteria></criteria>	<criteria></criteria>					
		Coating quality	A minimul immersed	n of 95% of the surfac	e being			
		<condition></condition>						
		Terminals of the capacit	tor shall be immersed	into solder bath at				
		$260\pm5$ °C for $10\pm1$ seco	onds or 400±10°C for 3	$8^{+1}_{-0}$ seconds to 1.5~2.0	mm from th			
		body of capacitor.		v				
	Resistance to	Then the capacitor shall	be left under the norm	al temperature and nor	mal humidit			
4.12	solder heat	for 1~2 hours before me		1				
	test	<criteria></criteria>						
		Leakage current	Not more than the	specified value.				
		Capacitance Change	Within $\pm 10\%$ of					
		tan δ	Not more than the					
		Appearance	There shall be no	leakage of electrolyte.				
		<condition></condition>						
		Temperature Cycle: Accord	ling to IEC60384-4No	.4.7methods, capacito	r shall be			
		placed in an oven, the cond	•	-				
			mperature	Time				
		(1)+20°C	•	≤3 Minutes				
	GI 6	(2)Rated low temperat	ture (-40°C) (-25°C)	$30\pm2$ Minutes				
4.13	Change of temperature	(3)Rated high tempera		30±2 Minutes				
4.13	test	(1) to (3)=1 cycle, total 5 cycle						
	test	<criteria></criteria>	ii 5 cycle					
		The characteristic shall me	et the following requir	rement				
		Leakage current			$\overline{}$			
		tan 8	Not more than the	specified value.				
		tan δ Appearance	Not more than the					
		tan δ Appearance <condition></condition>	Not more than the	specified value.				
		tan δ Appearance <condition> Humidity Test:</condition>	Not more than the There shall be no lo	specified value. eakage of electrolyte.				
		tan $\delta$ Appearance <b>Condition&gt;</b> Humidity Test: According to IEC60384-	Not more than the There shall be no least 4No.4.12methods, cap	specified value. eakage of electrolyte. eacitor shall				
		tan δ Appearance <condition> Humidity Test: According to IEC60384- be exposed for 500±8 h</condition>	Not more than the There shall be no load 4No.4.12methods, capours in an atmosphere	specified value. eakage of electrolyte. eacitor shall of 90~95%R H .at	lent			
		tan $\delta$ Appearance <b>Condition&gt;</b> Humidity Test: According to IEC60384-	Not more than the There shall be no load 4No.4.12methods, capours in an atmosphere	specified value. eakage of electrolyte. eacitor shall of 90~95%R H .at	nent.			
	Damp heat	tan $\delta$ Appearance <b>Condition&gt;</b> Humidity Test: According to IEC60384- $\delta$ be exposed for $\delta = 0.0000000000000000000000000000000000$	Not more than the There shall be no load 4No.4.12methods, capours in an atmosphere	specified value. eakage of electrolyte. eacitor shall of 90~95%R H .at	nent.			
4.14	Damp heat test	tan $\delta$ Appearance <b>Condition&gt;</b> Humidity Test: According to IEC60384-be exposed for $500\pm 8$ he $40\pm 2^{\circ}\mathrm{C}$ , the characterist <b>Criteria&gt;</b>	Not more than the There shall be no loss 4No.4.12methods, capours in an atmosphere tic change shall meet to	specified value. eakage of electrolyte. eacitor shall of 90~95%R H .at he following requirem	nent.			
4.14	_	tan $\delta$ Appearance <b>Condition&gt;</b> Humidity Test: According to IEC60384-be exposed for $500\pm 8$ he $40\pm 2^{\circ}\mathrm{C}$ , the characterist <b>Criteria&gt;</b> Leakage current	Not more than the There shall be no lot 4No.4.12methods, capours in an atmosphere tic change shall meet to the Not more than the specific change shall meet to the specific chan	specified value. eakage of electrolyte. eacitor shall of 90~95%R H .at he following requirem	ment.			
4.14	_	tan $\delta$ Appearance <b>Condition&gt;</b> Humidity Test: According to IEC60384-be exposed for $500\pm 8$ he $40\pm 2^{\circ}\mathrm{C}$ , the characterist <b>Criteria&gt;</b> Leakage current Capacitance Change	Not more than the $\pm$ There shall be no logarithms and $\pm$ 4No.4.12methods, capours in an atmosphere tic change shall meet to $\pm$ Not more than the specific Within $\pm$ 20% of initial	specified value. eakage of electrolyte. eacitor shall of 90~95%R H .at he following requirem ecified value. ial value.	eent.			
4.14	_	tan δ Appearance <condition> Humidity Test: According to IEC60384- be exposed for 500±8 h 40±2°C, the characterist  <criteria> Leakage current Capacitance Change tan δ</criteria></condition>	Not more than the $\frac{1}{2}$ There shall be no local 4No.4.12methods, capours in an atmosphere tic change shall meet to $\frac{1}{2}$ Not more than the specific within $\frac{1}{2}$ 20% of initial Not more than 120% of	specified value.  eakage of electrolyte.  eacitor shall of 90~95%R H .at he following requirem ecified value. ial value. of the specified value.	eent.			
4.14	_	tan δ Appearance <condition> Humidity Test: According to IEC60384- be exposed for 500±8 h 40±2°C, the characterist  <criteria> Leakage current Capacitance Change tan δ</criteria></condition>	Not more than the $\pm$ There shall be no logarithms and $\pm$ 4No.4.12methods, capours in an atmosphere tic change shall meet to $\pm$ Not more than the specific Within $\pm$ 20% of initial	specified value.  eakage of electrolyte.  eacitor shall of 90~95%R H .at he following requirem ecified value. ial value. of the specified value.	ment.			

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4.15	Vent test	<condition> The following test only  3 Æ6.3 with vent.  D.C. test The capacitor is connected current selected from be  <table 3="">  Diameter (mm)  22.4 or less  Over 22.4</table></condition>	ed with its po	olarity rever			
		<b>Criteria&gt;</b> The vent shall operate wing pieces of the capacitor and condition>		ous conditio	ons such as	flames or disp	persion o
		The maximum permiss at 120Hz and can be a Table-1 The combined value of the rated voltage and s  Frequency Multipliers  Coefficient  Cap. (µF)	pplied at max f D.C voltage hall not reve	ximum ope e and the p	rating temp eak A.C vo	erature	t exceed
	Maximum		0.20	0.40	0.80	1.00	
4.16	-						
	current)	220~	0.50	0.85	0.94	1.00	
	permissible (ripple current)	1~5.6 6.8~180 220~	0.20 0.40 0.50	0.40 0.75 0.85	0.80 0.90 0.94	1.00 1.00 1.00	

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

# **SAMXON**

5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

,	Substances				
	Cadmium and cadmium compounds				
Haavy matala	Lead and lead compounds				
Heavy metals	Mercury and mercury compounds				
	Hexavalent chromium compounds				
	Polychlorinated biphenyls (PCB)				
Chloinated	Polychlorinated naphthalenes (PCN)				
organic	Polychlorinated terphenyls (PCT)				
compounds	Short-chain chlorinated paraffins(SCCP)				
	Other chlorinated organic compounds				
Dog or in sect of	Polybrominated biphenyls (PBB)				
Brominated	Polybrominated diphenylethers(PBDE) (including				
organic	decabromodiphenyl ether[DecaBDE])				
compounds	Other brominated organic compounds				
Tributyltin comp	ounds(TBT)				
Triphenyltin com	pounds(TPT)				
Asbestos					
Specific azo com	pounds				
Formaldehyde					
Beryllium oxide					
Beryllium coppe	er				
Specific phthalate	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)				
Hydrofluorocarbo	on (HFC), Perfluorocarbon (PFC)				
Perfluorooctane s	sulfonates (PFOS)				
Specific Benzotri	azole				

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# ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

# SAMXON

#### **Attachment: Application Guidelines**

#### 1. Circuit Design

#### 1.1 Operating Temperature and Frequency

Electrolytic capacitor electrical parameters are normally specified at 20 °C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.

- (1) Effects of operating temperature on electrical parameters
  - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
  - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
  - a) At higher frequencies capacitance and impedance decrease while  $tan\delta$  increases.
  - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).

#### 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

#### 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

#### (1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

#### (2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

#### (3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

#### (4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

#### 1.4 Using Two or More Capacitors in Series or Parallel

#### (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

#### (2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

#### 1.5 Capacitor Mounting Considerations

#### (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

#### (2) Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

#### (3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

#### (4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

#### (5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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#### (6) Wiring Near the Pressure Relief Vent

Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite.

(7) Circuit Board patterns Under the Capacitor

Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.

(8) Screw Terminal Capacitor Mounting

Do not orient the capacitor with the screw terminal side of the capacitor facing downwards.

Tighten the terminal and mounting bracket screws within the torque range specified in the specification.

#### 1.6 Electrical Isolation of the Capacitor

Completely isolate the capacitor as follows.

- (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths
- (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
- 1.7 The Product endurance should take the sample as the standard.
- 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.

#### 1.9 Capacitor Sleeve

The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.

The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.

#### CAUTION!

Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use.

- (1) Provide protection circuits and protection devices to allow safe failure modes.
- (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.

#### 2. Capacitor Handling Techniques

- 2.1 Considerations Before Using
- (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.
- (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about  $1k\Omega$ .
- (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately  $1k\Omega$ .
- (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.
- (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.

#### 2.2 Capacitor Insertion

- (1) Verify the correct capacitance and rated voltage of the capacitor.
- (2) Verify the correct polarity of the capacitor before inserting.
- (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.
- (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.

For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.

#### 2.3 Manual Soldering

- (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.
- (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.
- (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.
- (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

### 2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.

#### 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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#### 2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.

#### 2.7 Circuit Board Cleaning

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60 °C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

Alkali solvents : could attack and dissolve the aluminum case.

Petroleum based solvents: deterioration of the rubber seal could result.

Xylene : deterioration of the rubber seal could result.

Acetone : removal of the ink markings on the vinyl sleeve could result.

- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

#### 2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

#### 3. Precautions for using capacitors

#### 3.1 Environmental Conditions

Capacitors should not be stored or used in the following environments.

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

#### 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

#### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a  $1000\Omega$ , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

#### 5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

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- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE	: Local	laws may	have specific	disposal	l requirements,	which	n must	be fol	lowed.
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